

**Notice of References Cited**

Application/Control No.

10/551,916

Applicant(s)/Patent Under  
Reexamination  
HUNT ET AL.

Examiner

/Susan W. Berman/

Art Unit

1796

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,338,766	08-1994	Phan et al.	521/63
*	B	US-6,261,679	07-2001	Chen et al.	428/317.9
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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